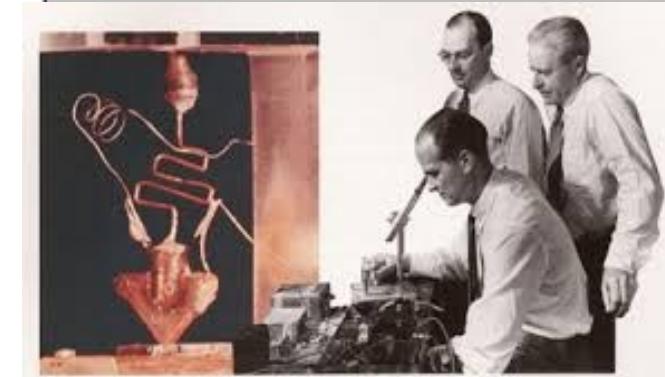
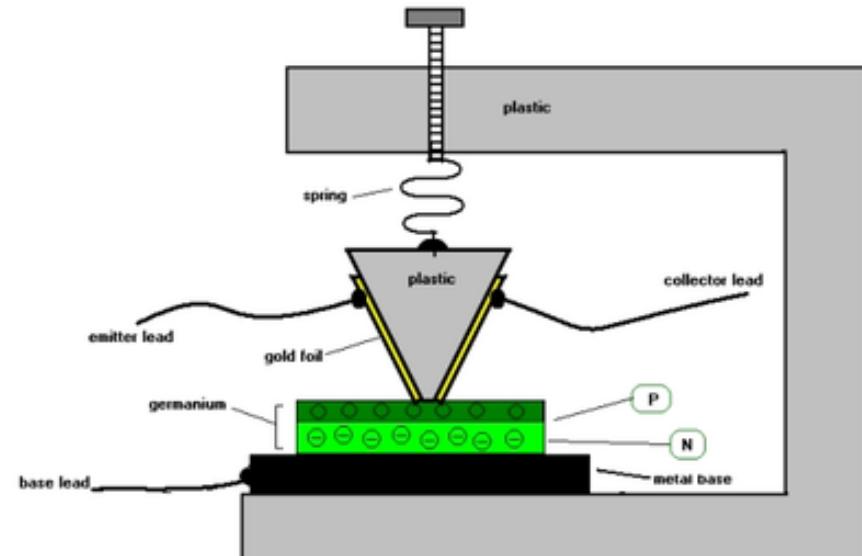


# Bipolar Junction Transistor (BJT)

# History

- Invented in 1947 by Shockley, Bardeen, and Brattain at Bell Laboratories.
- Awarded with the Nobel Prize
- Transistors were originally manufactured using Germanium.
- Today's Silicon-based transistors were adopted because Germanium breaks down at 180 degrees F
- It's a three terminal device.
- The name **transistor** is derived from the term **transfer resistance**.  
Transistor – Trans-Resistor
- The current (voltage) through two of the terminals is controlled by the current (voltage) through another pair of terminals.
- Transistor can act as a switch.
- Transistor has the ability to amplify a signal between one pair of terminals by using an input signal at another pair of terminals.  
Thus, a transistor can also act as an amplifier

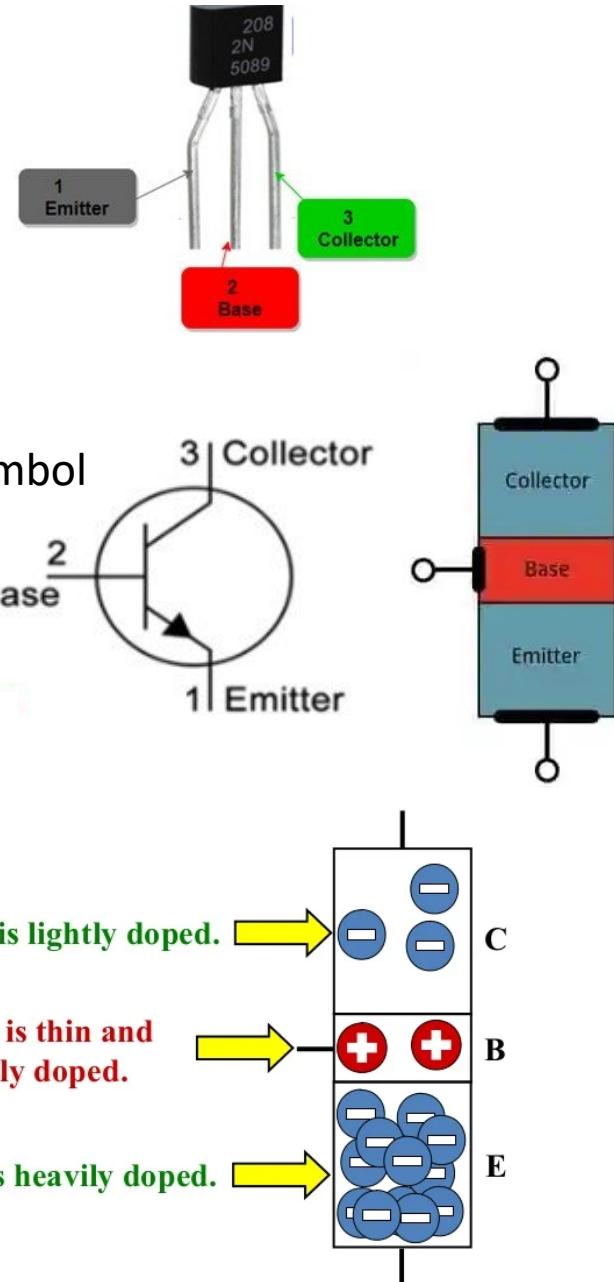


# Construction

- The BJT is a three terminal device and has two junctions
- The N and P regions are different both geometrically and in terms of the doping concentration of the regions
  - **Emitter region** - this is usually a heavily doped region (P/N). The emitter 'emits' the carriers into the base.
  - **Base region** - this is a lightly doped region. The base region is also physically thin so that carriers can pass through with minimal recombination.
  - **Collector region** - this is a lightly doped region. The collector region has a larger width than the other two regions since charge is accumulated here from the base.

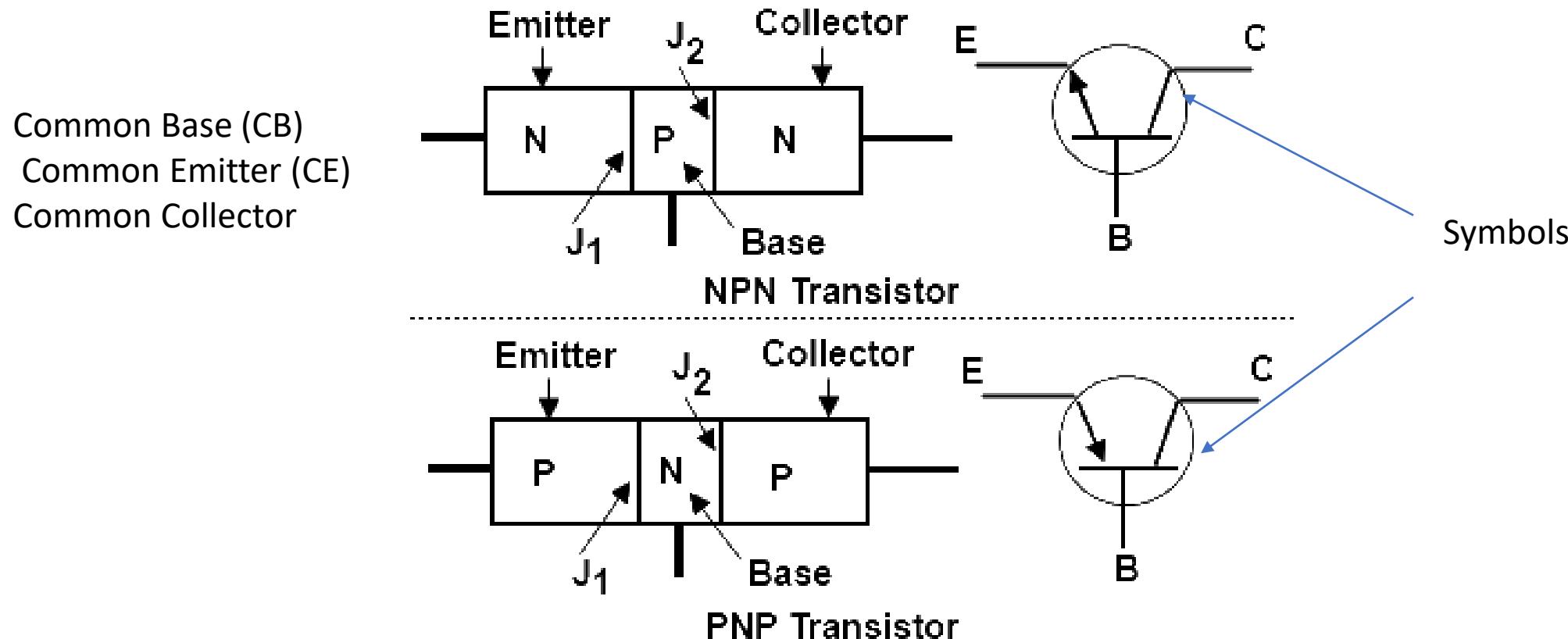
The **doping concentrations** in the collector, base and emitter are not the same

- Collector doping is usually  $\sim 10^6$
- Base doping is slightly higher  $\sim 10^7 - 10^8$
- Emitter doping is much higher  $\sim 10^{15}$



# Types of Transistors

Therefore the **behavior** of the device is **not electrically and geometrically symmetric** and the **terminals** cannot be **interchanged**



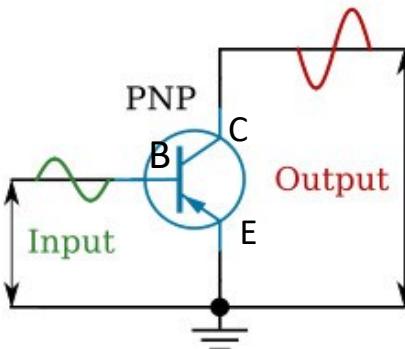
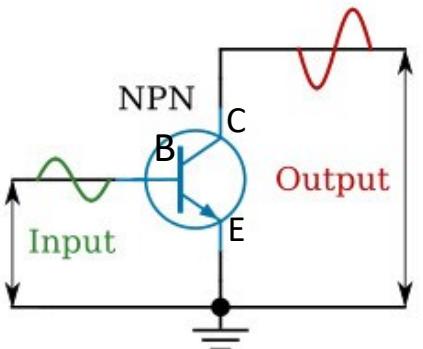
Note: NPN type is most **commonly used Transistor**. The **majority charge carriers** in an [NPN transistor](#) are **electrons** and the majority carriers in a PNP transistor are **holes**. The **electrons have better mobility** than **holes** and **helps in better conduction**.

# Modes of Operation

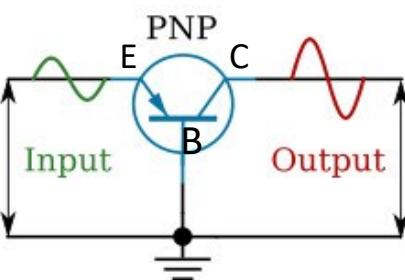
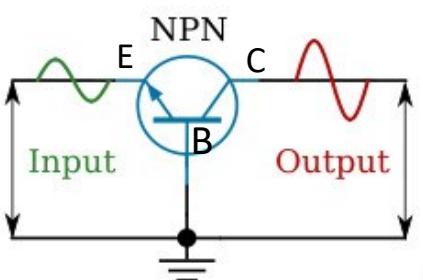
- Active
  - Most important mode of operation
  - offer **amplifier operation**, The region where current curves are practically flat
- Saturation
  - Barrier potential of the junctions cancel out each other causing a virtual short-closed switch
- Cut-Off
  - Current reduced to zero, Ideal transistor behaves like an **open switch**

<b>Region of operation</b>	<b>Base Emitter Junction</b>	<b>Collector Base Junction</b>	<b>Application</b>
Cut off	Reverse biased	Reverse biased	As a switch
Active	Forward biased	Reverse biased	As an amplifier
Saturation	Forward biased	Forward biased	As a switch

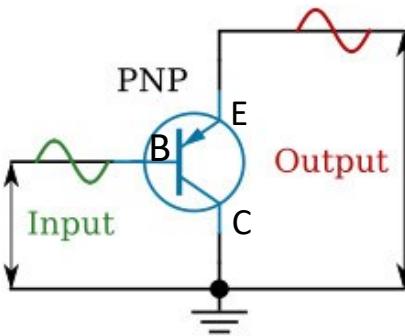
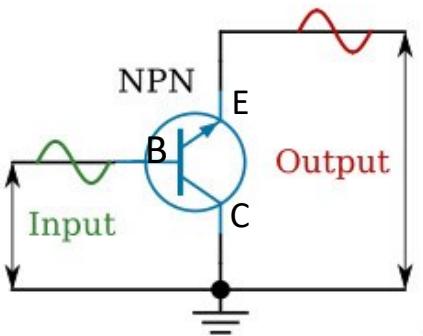
# BJT Configurations



Common emitter



Common base



Common collector

## Common Emitter(CE):

Input = V<sub>BE</sub> & I<sub>B</sub>

Output = V<sub>CE</sub> & I<sub>C</sub>

## Common-Base (CB)

Input = V<sub>EB</sub> & I<sub>E</sub>

Output = V<sub>CB</sub> & I<sub>C</sub>

## Common-Collector (CC)

Input = V<sub>BC</sub> & I<sub>B</sub>

Output = V<sub>EC</sub> & I<sub>E</sub>

# Common Base Transistor

## Biassing in CB mode:

- Emitter–Base junction (EBJ): **Forward biased** → allows electrons to flow from emitter into base.
- Collector–Base junction (CBJ): **Reverse biased** → attracts electrons from base into collector.  
So, **base is common**, emitter acts as input, collector as output.

## Working Principle

### Electron Injection (Emitter $\rightarrow$ Base):

Forward bias at EBJ pushes electrons (majority carriers of emitter) into the base.

### Carrier Transport through Base:

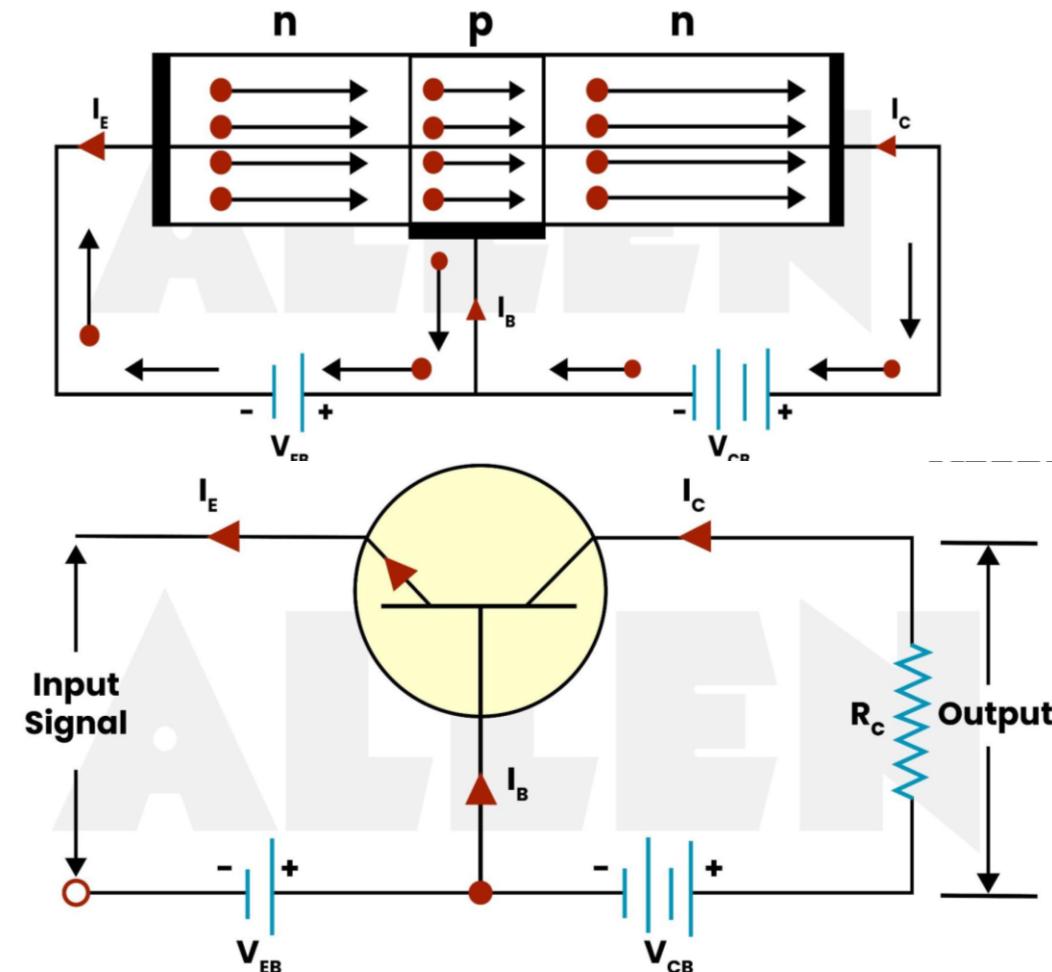
The base is very **thin and lightly doped**, so only a few electrons recombine with holes.

Most electrons diffuse across the base into the collector region.

### Electron Collection (Base $\rightarrow$ Collector):

Reverse-biased CBJ creates a strong electric field. This field sweeps electrons from the base into the collector  $\rightarrow$  large **collector current**.

Thus, **emitter current flows  $\rightarrow$  majority of it appears as collector current**, with a very small base current due to recombination.



# Current Relations and equations

$I_E$  = Emitter Current ,  $I_B$  = Base Current,  $I_c$  = Collector Current

(a) KCL

$$I_E = I_B + I_c$$

(a) Current gain ( $\alpha$ ) in CB:

$$\alpha = \frac{I_c}{I_E}, \quad 0.95 \leq \alpha \leq 0.99$$

(c) Collector Current equation:

$$I_c = \alpha I_E + I_{CBO}$$

Where  $I_{CBO}$  = reverse leakage current of CB junction (small)

(d) Input equation (Diode-like behaviour): Since EBJ is forward biased

$$I_E \approx I_s \left( e^{\frac{V_{BE}}{V_T}} - 1 \right)$$

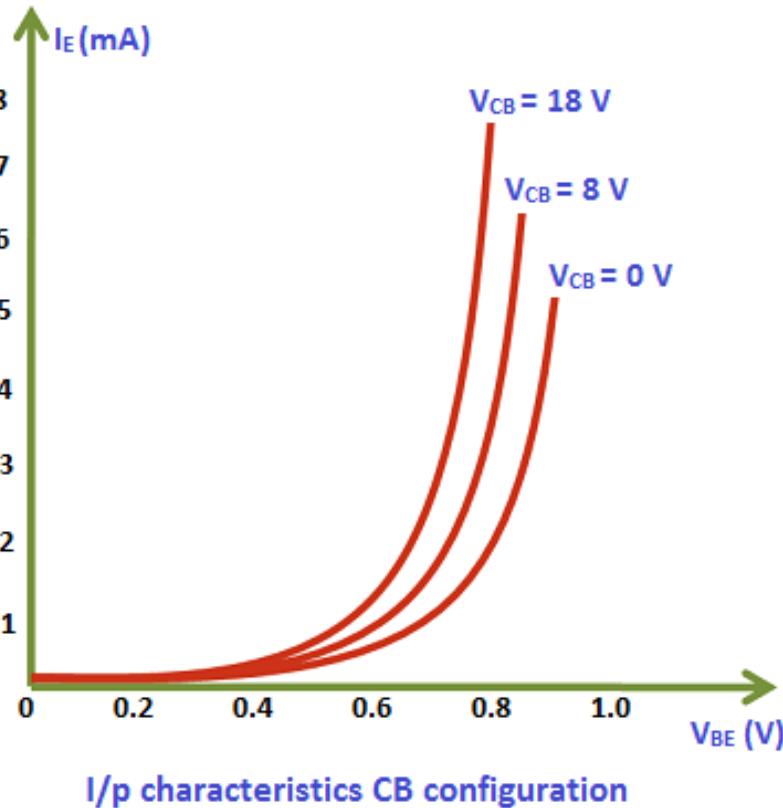
Where  $I_s$  = saturation current ,  $V_T = 26 \text{ mV}$  at  $300^\circ K$

(e) Output relation:

$$I_c \approx \alpha I_E \quad (\text{since } \ll I_E)$$

# Input characteristic (CB)

$I_E$  vs  $V_{BE}$  (like diode curve).



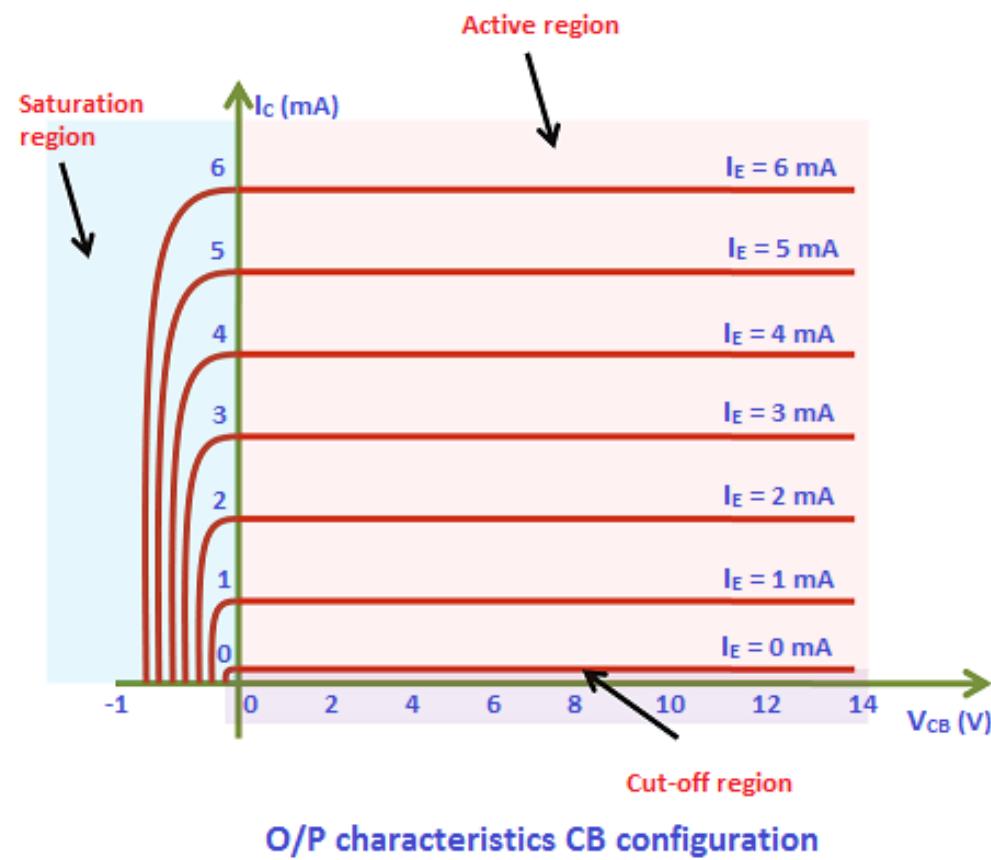
- The input circuit (Emitter–Base junction) is a forward biased p–n junction, so it behaves like a diode characteristic.
- For small  $V_{BE}$ ,  $I_E \approx 0$ .
- After crossing the threshold ( $\sim 0.3$  V for Ge,  $\sim 0.7$  V for Si), emitter current rises rapidly (Exponential) with small increase in  $V_{BE}$

**Input resistance  $R_{in}$**  : very low (tens of ohms)

$$R_{in} = \frac{\Delta V_{BE}}{\Delta I_E}$$

The  $I_E \uparrow$  with  $V_{CB}$  (The reason is base width modulation)  
When  $V_{CB}$  increases, the depletion region at CB junction widens inside the base. A thinner base means less chance of recombination of electrons (from emitter) with holes in the base. So, more electrons injected from the emitter can cross into the collector.

# Output characteristic (CB)



O/p chara. is relationship between output current  $I_c$  and output voltage  $V_{CB}$  keeping input current  $I_E$  constant.

When  $I_E = 0 \text{ mA}$ , the transistor operates in the cut-off region.

In saturation region both emitter base junction and collector base junction are forward biased.

## Nature of curve:

- For small  $V_{CB}$  : a little rise in  $I_c$  (due to Early effect).
- After that:  $I_c$  remains almost constant for given  $I_E$  , independent of  $V_{CB}$
- Different curves for different  $I_E$  values

## Regions in Output Characteristics

- **Cut-off region:**  $I_E = 0 \text{ mA}$ , so  $I_c \approx 0 \text{ mA}$  (tiny leakage current).
- **Active region:** CBJ reverse biased, EBJ forward biased → transistor action occurs (amplifier mode).
- **Saturation region:** Both junctions forward biased →  $I_c$  increases sharply, transistor cannot amplify.

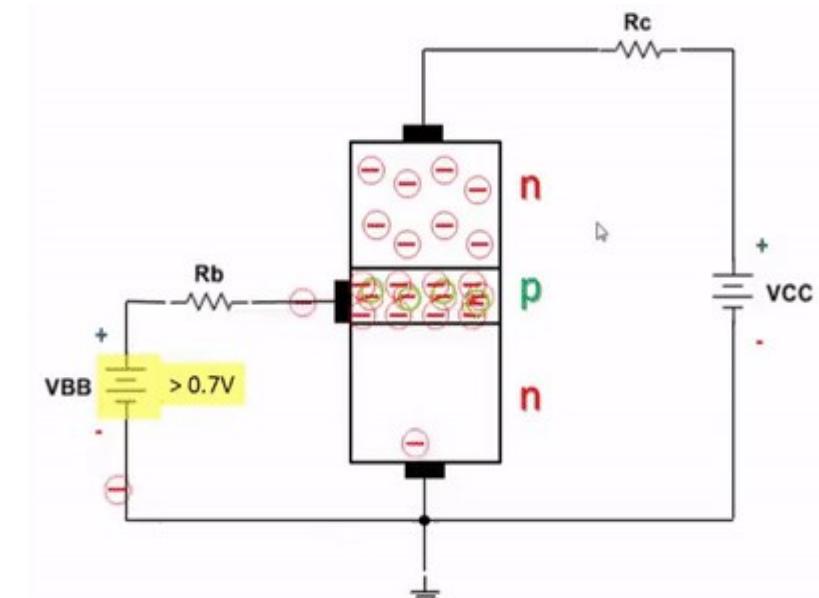
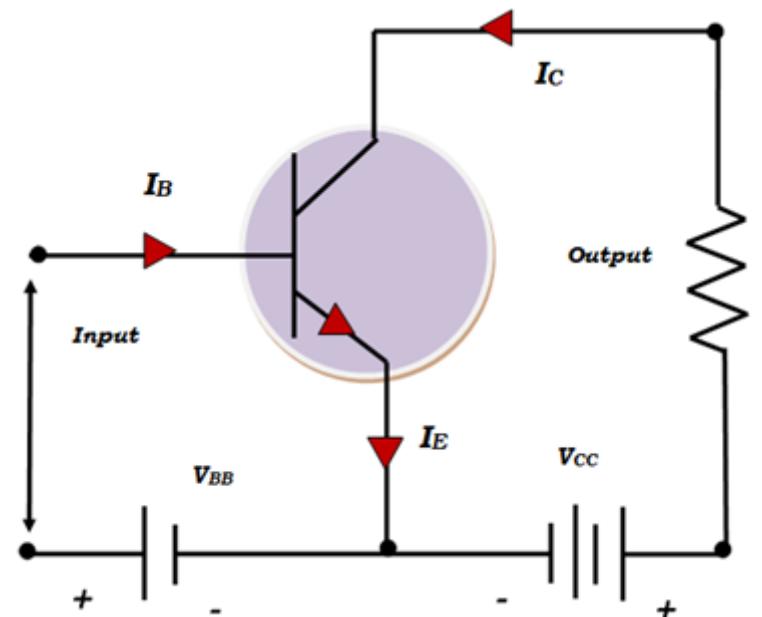
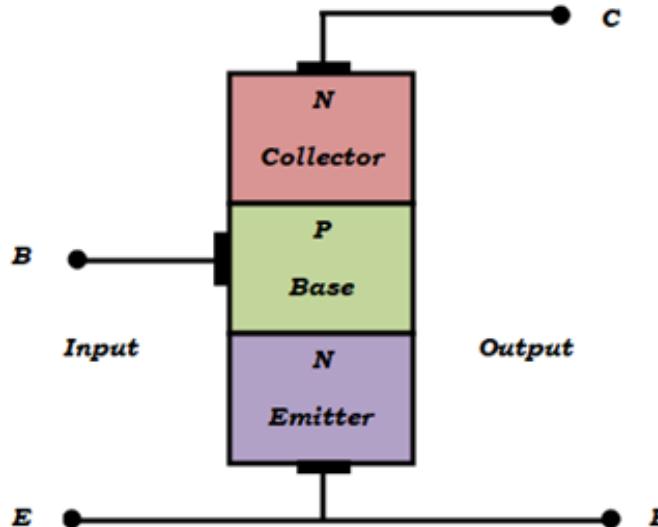
$$I_c = \alpha I_E + I_{CBO}$$

O/P resistance  $R_{out}$ : very high( $\text{k}\Omega$ )

$$R_{out} = \frac{\Delta V_{CB}}{\Delta I_c}$$

# Common Emitter Transistor

- ✓ In CE configuration, the emitter terminal is grounded and the input signal is applied between the base and emitter terminals while the output signal is taken between the collector and emitter terminals
- ✓ It is most widely used configuration.
- ✓ The common emitter amplifier has medium input and output impedance levels.
- ✓ The **current gain** and **voltage gain** of the **common emitter** amplifier is medium. However, the power gain is high.
- ✓ Input current  $I_B$  is measured in  $\mu\text{A}$  because the base region is very lightly doped



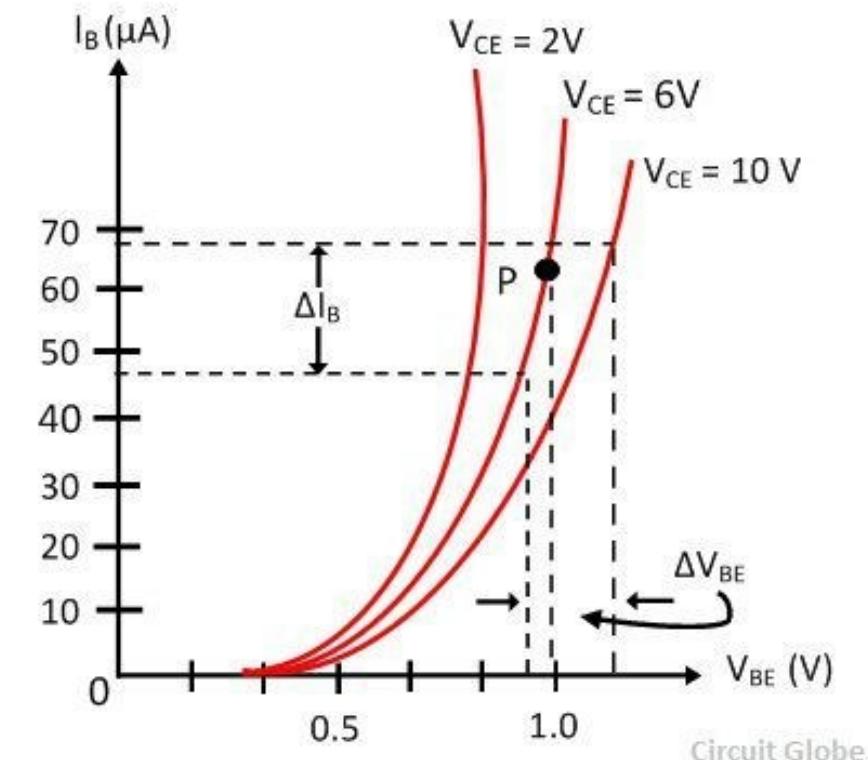
# Input Characteristics (CE mode)

Variation of  $I_B$  with  $V_{BE}$  at constant  $V_{CE}$

**Behaviour:**

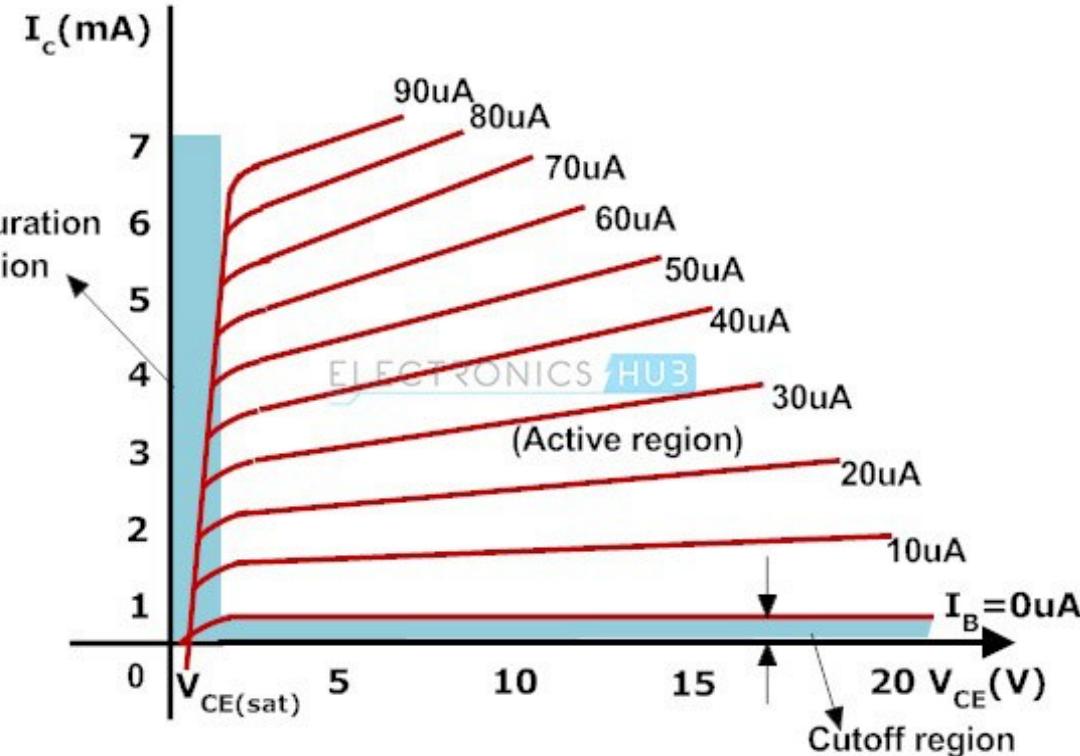
- The input junction (B-E) is a **forward-biased diode**.
- For **small  $V_{BE}$**   $\rightarrow I_B \approx 0$
- When  $V_{BE}$  exceeds  $\sim 0.7$  V (Si) or  $\sim 0.3$  V (Ge),  $I_B$  increases **exponentially**.
- With **higher  $V_{CE}$**  :
  - The collector-base depletion region widens (Early effect). Base width reduces  $\rightarrow$  less recombination  $\rightarrow$  slightly less base current needed for same  $V_{BE}$  .
  - So, input curve shifts a little downward with increasing  $V_{CE}$  .

$$I_E = I_C + I_B$$
$$\text{Current gain } \beta = \frac{I_c}{I_B} \quad (20-500 \text{ typically})$$
$$\beta = \frac{\alpha}{1 - \alpha} \qquad \qquad \alpha = \frac{\beta}{1 + \beta}$$



# Output Characteristics (CE mode)

Variation of  $I_c$  with  $V_{CE}$  at constant  $I_B$



## Cut-off Region ( $I_B = 0$ ):

- Both junctions reverse biased
- Only a tiny leakage current flows ( $I_{CBO}$ ).

## Active Region:

- $I_c$  increases almost linearly with  $I_B$ .
- For a given  $I_B$ ,  $I_c \approx \beta I_B$
- Output curves (for different  $I_B$ ) are nearly flat but rise slightly with  $V_{CE}$  (Early effect).

## Saturation Region:

- When  $V_{CE}$  is small ( $\leq 0.2$  V), both junctions FB
- $I_c$  increases sharply  $\rightarrow$  transistor fully ON.

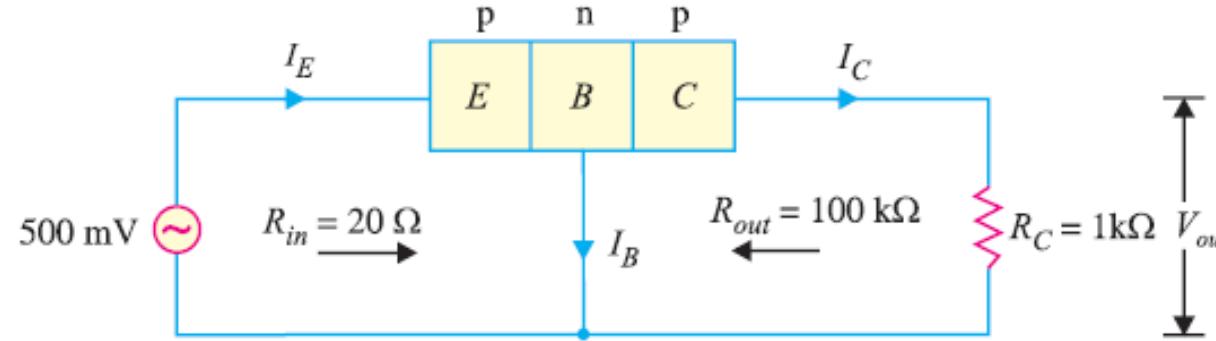
$\uparrow V_{CE} = \uparrow V_{CB} + V_{BE}$ , hence  $I_B \downarrow I_c \uparrow$   
“Base width Modulation or early effect”

$$\text{O/P resistance } R_{out} = \left. \frac{\Delta V_{CE}}{\Delta I_c} \right|_{I_B} \text{ typically high (k}\Omega\text{)}$$

# BJT Configurations-Comparison

<b>AMPLIFIER TYPE</b>	<b>COMMON BASE</b>	<b>COMMON Emitter</b>	<b>COMMON COLLECTOR</b>
<b>INPUT/OUTPUT PHASE RELATIONSHIP</b>	<b>0°</b>	<b>180°</b>	<b>0°</b>
<b>VOLTAGE GAIN</b>	<b>HIGH</b>	<b>MEDIUM</b>	<b>LOW</b>
<b>CURRENT GAIN</b>	<b>LOW</b>	<b>MEDIUM</b>	<b>HIGH</b>
<b>POWER GAIN</b>	<b>LOW</b>	<b>HIGH</b>	<b>MEDIUM</b>
<b>INPUT RESISTANCE</b>	<b>LOW</b>	<b>MEDIUM</b>	<b>HIGH</b>
<b>OUTPUT RESISTANCE</b>	<b>HIGH</b>	<b>MEDIUM</b>	<b>LOW</b>

**Q1.** A common base transistor amplifier has an input resistance of  $20 \Omega$  and output resistance of  $100 \text{ k}\Omega$ . The collector load is  $1 \text{ k}\Omega$ . If a signal of  $500 \text{ mV}$  is applied between emitter and base, find the voltage amplification. Assume  $\alpha_{ac}$  to be nearly one.

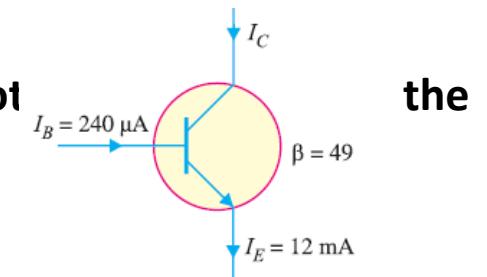


**Q2.** In a common base connection, current amplification factor is  $0.9$ . If the emitter current is  $1\text{mA}$ , determine the value of base current.

**Q3.** In a common base connection, the emitter current is  $1\text{mA}$ . If the emitter circuit is open, the collector current is  $50 \mu\text{A}$ . Find the total collector current. Given that  $\alpha = 0.92$ .

**Q4.** Calculate  $I_E$  in a transistor for which  $\beta = 50$  and  $I_B = 20 \mu\text{A}$ . ( $1.02 \text{ mA}$ )

**Q5.** Find the  $\alpha$  rating of the transistor shown in Fig. 4. Hence determine the value of  $I_C$  using both the transistor. ( $I_C = 11.76 \text{ mA}$ )



# Common Collector Transistor (CC)

The input circuit is connected between **emitter and base** and the output is taken from the **collector and emitter**, collector is common between emitter and base

The ratio of change in emitter current to the change in base current is known as the **current amplification factor**

Relation Between Y and  $\alpha$

$$\gamma = \frac{\Delta I_E}{\Delta I_B} \quad \alpha = \frac{\Delta I_E}{\Delta I_B}$$

$$I_E = I_c + I_B$$

$$\Delta I_E = \Delta I_c + \Delta I_B$$

$$\Delta I_B = \Delta I_E - \Delta I_c$$

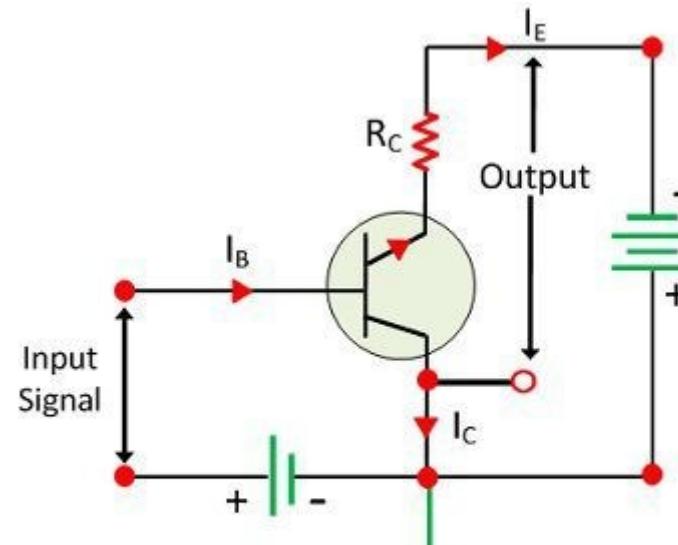
$$\gamma = \frac{\Delta I_E}{\Delta I_E - \Delta I_c}$$

$$\gamma = \frac{\Delta I_E / \Delta I_E}{\Delta I_E / \Delta I_E - \Delta I_c / \Delta I_E}$$

$$\gamma = \frac{\Delta I_E / \Delta I_E}{\Delta I_E / \Delta I_E - \Delta I_c / \Delta I_E}$$

$$\gamma = \frac{1}{1 - \Delta I_c / \Delta I_E}$$

$$\gamma = \frac{1}{1 - \alpha}$$



NPN Transistor

Circuit Globe

$\gamma$  is nearly equal to  $\beta$ , this arrangement input resistance is high, and output resistance is very low.

$$I_c = \alpha I_E + I_{CBO}$$

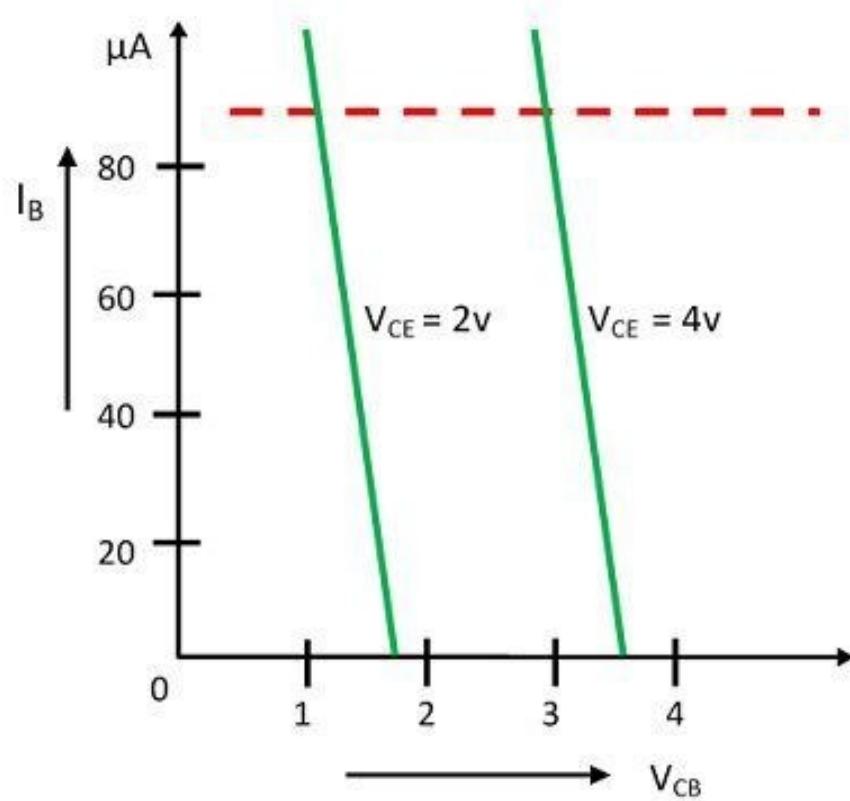
$$I_E = I_c + I_B = (\alpha I_B + I_{CBO}) + I_B$$

$$I_E (1 - \alpha) = I_{CBO} + I_B = \frac{I_{CBO}}{(1-\alpha)} + \frac{I_B}{(1-\alpha)}$$

$$I_E = I_B (1 + \beta) + I_{CBO} (1 + \beta)$$

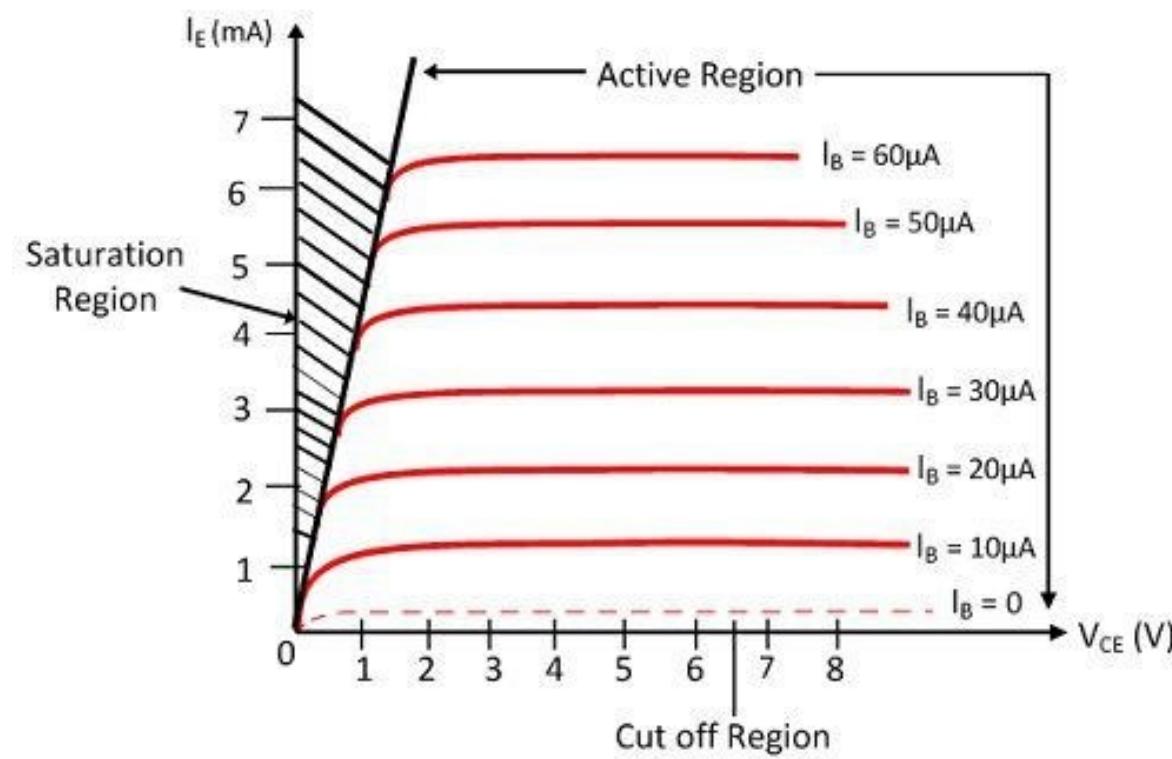
# Input / Output Characteristic Curve

The voltage gain of the resistance is very low. This circuit arrangement is mainly used for impedance matching.



**Input Characteristic Curve**

Circuit Globe



**Output Characteristic Curve**

Circuit Globe